

## Is Now Part of



## ON Semiconductor®

# To learn more about ON Semiconductor, please visit our website at www.onsemi.com

Please note: As part of the Fairchild Semiconductor integration, some of the Fairchild orderable part numbers will need to change in order to meet ON Semiconductor's system requirements. Since the ON Semiconductor product management systems do not have the ability to manage part nomenclature that utilizes an underscore (\_), the underscore (\_) in the Fairchild part numbers will be changed to a dash (-). This document may contain device numbers with an underscore (\_). Please check the ON Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at <a href="www.onsemi.com">www.onsemi.com</a>. Please email any questions regarding the system integration to Fairchild <a href="general-regarding-numbers-n

ON Semiconductor and the ON Semiconductor logo are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officer



## **FDC6420C**

## 20V N & P-Channel PowerTrench® MOSFETs

### **General Description**

These N & P-Channel MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize on-state resistance and yet maintain superior switching performance.

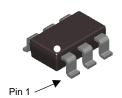
These devices have been designed to offer exceptional power dissipation in a very small footprint for applications where the bigger more expensive SO-8 and TSSOP-8 packages are impractical.

## **Applications**

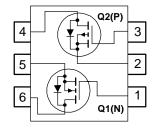
- DC/DC converter
- Load switch
- · LCD display inverter

#### **Features**

- Q1 3.0 A, 20V.  $R_{DS(ON)} = 70~m\Omega @V_{GS} = 4.5~V$   $R_{DS(ON)} = 95~m\Omega @V_{GS} = 2.5~V$
- Q2 –2.2 A, 20V.  $R_{DS(ON)} = 125 \text{ m}\Omega$  @  $V_{GS} = -4.5 \text{ V}$   $R_{DS(ON)} = 190 \text{ m}\Omega$  @  $V_{GS} = -2.5 \text{ V}$
- · Low gate charge
- High performance trench technology for extremely low  $R_{\text{DS(ON)}}$ .
- SuperSOT –6 package: small footprint (72% smaller than SO-8); low profile (1mm thick).



SuperSOT™-6



Absolute Maximum Ratings T <sub>A=25°C</sub> un	nless otherwise noted
---	-----------------------

Symbol	Parameter		Q1	Q2	Units
V <sub>DSS</sub>	Drain-Source Voltage		20	-20	V
V <sub>GSS</sub>	Gate-Source Voltage		±12	±12	V
I <sub>D</sub>	Drain Current - Continuous	(Note 1a)	3.0	-2.2	Α
	– Pulsed		12	-6	
P <sub>D</sub>	Power Dissipation for Single Operation	(Note 1a)	0.0	96	
		(Note 1b)	0.	9	W
		(Note 1c)	0.	7	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		–55 to	+150	°C

## **Thermal Characteristics**

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	130	°C/W
R <sub>eJC</sub>	Thermal Resistance, Junction-to-Case	(Note 1)	60	°C/W

## **Package Marking and Ordering Information**

Device Marking	Device	Reel Size	Tape width	Quantity
.420	FDC6420C	7"	8mm	3000 units

Symbol	I Parameter		Test Conditions		Min	Тур	Max	Units	
Off Char	acteristics								
BV <sub>DSS</sub>	Drain-Source Breakdown Volta	ge	$V_{GS} = 0 \text{ V}, \qquad I_D = 250 \mu\text{A} \ V_{GS} = 0 \text{ V}, \qquad I_D = -250 \mu\text{A}$	Q1 Q2	20 –20			V	
<u>ΔBV<sub>DSS</sub></u> ΔT <sub>J</sub>	Breakdown Voltage Temperatur	re	$I_D = 250 \mu A$ , Ref. to 25°C $I_D = -250 \mu A$ , Ref. to 25°C	Q1 Q2		13 –11		mV/°C	
I <sub>DSS</sub>	Zero Gate Voltage Drain Currer	nt	$V_{DS} = 16 \text{ V},  V_{GS} = 0 \text{ V}$ $V_{DS} = -16 \text{ V},  V_{GS} = 0 \text{ V}$	Q1 Q2			1 -1	μΑ	
I <sub>GSSF</sub>	Gate-Body Leakage, Forward		$V_{GS} = 12 \text{ V},  V_{DS} = 0 \text{ V} $ $V_{GS} = 12 \text{ V},  V_{DS} = 0 \text{ V}$	Q1 Q2			100 100	nA	
I <sub>GSSR</sub>	Gate-Body Leakage, Reverse		$V_{GS} = -12 \text{ V},  V_{DS} = 0 \text{ V}$ $V_{GS} = -12 \text{ V},  V_{DS} = 0 \text{ V}$	Q1 Q2			-100 -100	nA	
On Char	acteristics (Note 2)								
$V_{GS(th)}$	Gate Threshold Voltage	Q1	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$		0.5	0.9	1.5	V	
		Q2	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$		-0.6	-1.0	-1.5		
$\Delta V_{GS(th)}$	Gate Threshold Voltage	Q1	I <sub>D</sub> = 250 μA, Ref. To 25°C			-3		mV/°C	
$\Delta T_{J}$	Temperature Coefficient	Q2	$I_D = -250 \mu\text{A}$ , Ref. to 25°C			-3			
R <sub>DS(on)</sub>	Static Drain–Source	Q1	$V_{GS} = 4.5 \text{ V}, I_D = 3.0 \text{ A}$			50	70	mΩ	
D3(011)	On–Resistance		$V_{GS} = 2.5 \text{ V},  I_D = 2.5 \text{ A}$			66	95		
			$V_{GS} = 4.5 \text{ V}, I_D = 3.0 \text{ A}, T_J = 12$	25°C		71	106		
		Q2	$V_{GS} = -4.5 \text{ V}, I_D = -2.2 \text{ A}$			100	125		
			$V_{GS} = -2.5 \text{ V}, I_D = -1.8 \text{ A}$ $V_{GS} = -4.5 \text{ V}, I_D = -2.2 \text{ A}, T_J = 1$	25°C		145 137	190 184		
I <sub>D(on)</sub> On–State Drain Current		Q1	$V_{GS} = 4.5 \text{ V},  V_{DS} = 5 \text{ V}$		12	137	101	Α	
Totale Brain Surren	On State Brain Surrent	Q2	$V_{GS} = -4.5 \text{ V}, V_{DS} = -5 \text{ V}$		-6				
a Forward Trans	Forward Transconductance	Q1	$V_{DS} = 5 \text{ V}$ $I_{D} = 2.5 \text{ A}$		_0	10		S	
g <sub>FS</sub> Forward Transconductance		Q2	$V_{DS} = -5 \text{ V}$ $I_D = -2.0 \text{A}$			6			
Dynamic	Characteristics	42	50 - 5 -						
	Input Capacitance	Q1	V <sub>DS</sub> =10 V, V <sub>GS</sub> = 0 V, f=1.0M	IH <sub>7</sub>		324		nE	
$C_{iss}$	Input Capacitance	Q2	$V_{DS}=10 \text{ V}, \text{ V}_{GS}=0 \text{ V}, \text{ I=1.0}\text{ V}$ $V_{DS}=-10 \text{ V}, \text{ V}_{GS}=0 \text{ V}, \text{ f=1.0}\text{ I}$			337		pF	
<u> </u>	Output Conscitones		$V_{DS}=10 \text{ V}, \text{ V}_{GS}=0 \text{ V}, \text{ I}=1.00 \text{ V}$					"F	
Coss	Output Capacitance	Q1	$V_{DS}=10 \text{ V}, V_{GS}=0 \text{ V}, I=1.000$ $V_{DS}=-10 \text{ V}, V_{GS}=0 \text{ V}, f=1.00$			82		pF	
	December Transfer Committee	Q2	20 7 00 7			88			
$C_{rss}$	Reverse Transfer Capacitance	Q1	$V_{DS}=10 \text{ V}, V_{GS}=0 \text{ V}, f=1.0 \text{M}$			42		pF	
		Q2	$V_{DS}$ =-10 V, V $_{GS}$ = 0 V, f=1.01	VIHZ		51			
Switchin	g Characteristics (Note 2)	1	1		ı	1	Т		
$t_{d(on)}$	Turn-On Delay Time	Q1	For <b>Q1</b> :			5	10	ns	
		Q2	$V_{DS} = 10 \text{ V},  I_{DS} = 1 \text{ A}$			9	18		
t <sub>r</sub>	Turn-On Rise Time	Q1	$V_{GS}$ = 4.5 V, $R_{GEN}$ = 6 $\Omega$			7	14	ns	
	T 0"D   T	Q2	For <b>Q2</b> : V <sub>DS</sub> =–10 V, I <sub>DS</sub> = –1 A			12	22		
$t_{d(off)}$	Turn-Off Delay Time	Q1	$V_{DS} = -10 \text{ V},  I_{DS} = -1 \text{ A}$ $V_{GS} = -4.5 \text{ V},  R_{GEN} = 6 \Omega$			13	23	ns	
	Turn Off Fall Time	Q2	J. J			10	20 3	,	
t <sub>f</sub>	Turn–Off Fall Time	Q1 Q2	-			1.6 5	10	ns	
0	Total Gate Chargo	Q1	F 04			3.3	4.6	r.C	
$Q_g$	Total Gate Charge	Q2	For <b>Q1</b> : V <sub>DS</sub> = 10 V, I <sub>DS</sub> = 3.0 A			3.7	7.0	nC	
Q <sub>gs</sub>	Gate-Source Charge	Q1	$V_{GS} = 4.5 \text{ V},$			0.95		nC	
~ys	Jako Joan do Oriango	Q2	For <b>Q2</b> :			0.68			
Q <sub>gd</sub>	Gate-Drain Charge	Q1	$V_{DS} = -10 \text{ V},  I_{DS} = -2.2 \text{ A}$ $V_{GS} = -4.5 \text{ V},$			0.7		nC	
gu		Q2	v <sub>GS</sub> = -4.5 v,			1.3			

## **Electrical Characteristics**

T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter Test Condition		ns	Min	Тур	Max	Units	
Drain-Se	Drain-Source Diode Characteristics and Maximum Ratings							
Is	Maximum Continuous Drain—Source Diode Forward Current			Q1			0.8	Α
							-0.8	
V <sub>SD</sub>	Drain-Source Diode Forward	$V_{GS} = 0 \text{ V}, I_{S} = 0.8 \text{ A}$	(Note 2)		0.7	1.2	V	
Voltage		Q2	$V_{GS} = 0 \text{ V}, I_{S} = 0.8 \text{ A}$	(Note 2)		-0.8	-1.2	

#### Notes:

 R<sub>8JA</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R<sub>8JC</sub> is guaranteed by design while R<sub>9CA</sub> is determined by the user's board design.



a) 130 °C/W when mounted on a 0.125 in² pad of 2 oz. copper.



b) 140 °C/W when mounted on a .004 in<sup>2</sup> pad of 2 oz copper



c) 180 C°/W when mounted on a minimum pad.

Scale 1:1 on letter size paper

2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%

## **Typical Characteristics: N-Channel**

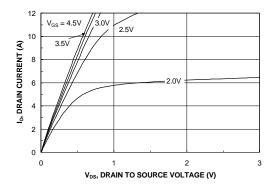


Figure 1. On-Region Characteristics.

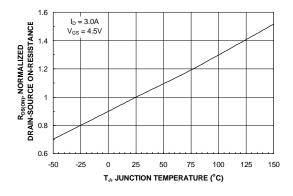


Figure 3. On-Resistance Variation with Temperature.

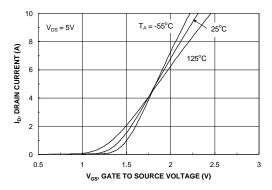


Figure 5. Transfer Characteristics.

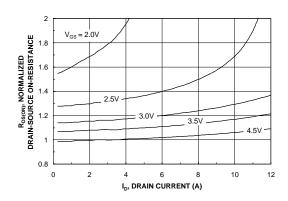


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

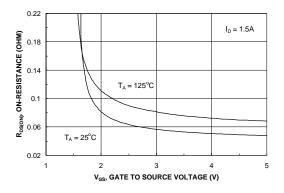


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

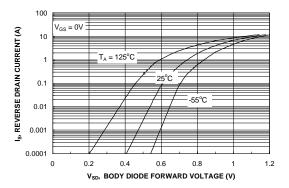
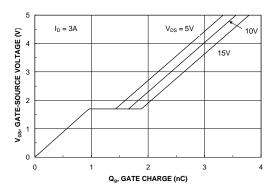


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

## **Typical Characteristics**



450
360
360
C<sub>ISS</sub>
0
0
5
10
15
20
V<sub>DS</sub>, DRAIN TO SOURCE VOLTAGE (V)

Figure 7. Gate Charge Characteristics.

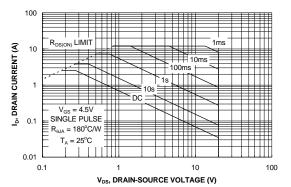


Figure 8. Capacitance Characteristics.

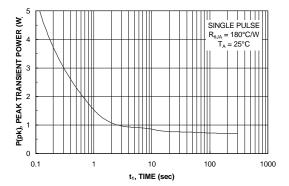
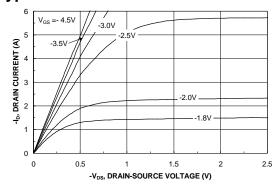


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

## **Typical Characteristics: P-Channel**



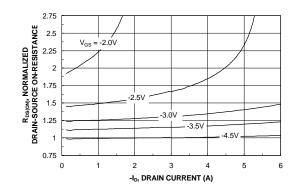
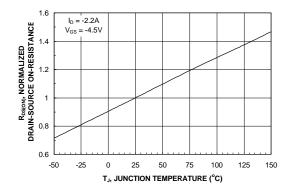


Figure 11. On-Region Characteristics.

Figure 12. On-Resistance Variation with Drain Current and Gate Voltage.



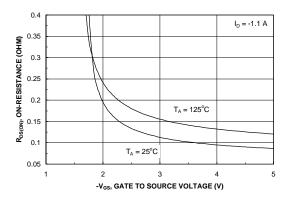
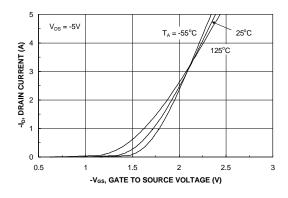


Figure 13. On-Resistance Variation with Temperature.

Figure 14. On-Resistance Variation with Gate-to-Source Voltage.



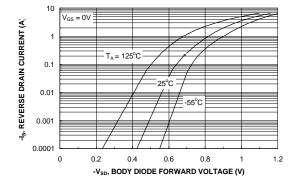
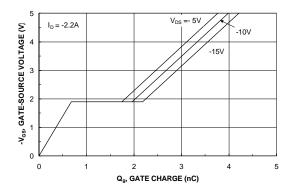


Figure 15. Transfer Characteristics.

Figure 16. Body Diode Forward Voltage Variation with Source Current and Temperature.

## **Typical Characteristics**



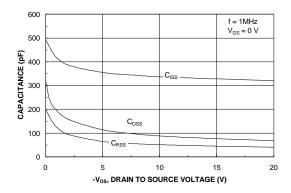
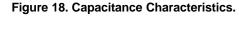
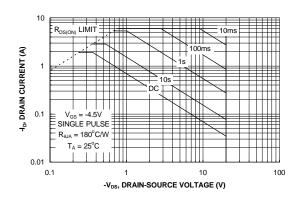


Figure 17. Gate Charge Characteristics.





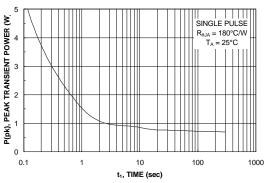


Figure 19. Maximum Safe Operating Area.

Figure 20. Single Pulse Maximum Power Dissipation.

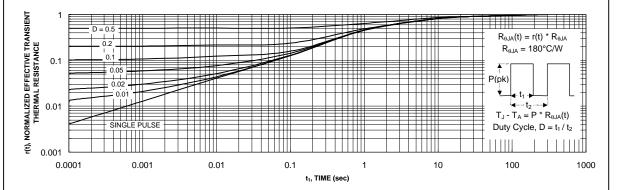


Figure 21. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.

#### **TRADEMARKS**

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

SMART START™  $VCX^{TM}$ FAST ® OPTOLOGIC™ STAR\*POWER™ FASTr™ Bottomless™ OPTOPLANAR™ Stealth™ CoolFET™ FRFET™ PACMAN™ SuperSOT™-3 CROSSVOLT™ GlobalOptoisolator™ POP™ SuperSOT™-6 DenseTrench™ GTO™ Power247™  $HiSeC^{TM}$ SuperSOT™-8  $Power Trench^{\, @}$ DOME™ SyncFET™ EcoSPARK™ ISOPLANAR™ QFET™ TinyLogic™ E<sup>2</sup>CMOS<sup>TM</sup> LittleFET™  $OS^{TM}$ 

EnSigna™ MicroFET™ QT Optoelectronics™ TruTranslation™
FACT™ MicroPak™ Quiet Series™ UHC™
FACT Quiet Series™ MICROWIRE™ SILENT SWITCHER® UltraFET®

STAR\*POWER is used under license

#### DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

#### LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the

2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

#### PRODUCT STATUS DEFINITIONS

### **Definition of Terms**

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.

Rev. H4

ON Semiconductor and in are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at <a href="www.onsemi.com/site/pdt/Patent-Marking.pdf">www.onsemi.com/site/pdt/Patent-Marking.pdf</a>. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and exp

## **PUBLICATION ORDERING INFORMATION**

#### LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800-282-9855 Toll Free USA/Canada
Europe, Middle East and Africa Technical Support:
Phone: 421 33 790 2910
Japan Customer Focus Center
Phone: 81-3-5817-1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative